

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, Dan Jose, CA 95138

PRODUCT/PROCESS CHANGE NOTICE (PCN)

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PCN #: A0702-01 D	ATE: 22-Mar-2007	Iar-2007 MEANS OF DISTINGUISHING CHANGED DEVICES:			
Product Affected: 24.5mm x 19.5mm FCBGA-655 Refer to attachment II for the affected part numbers. Date Effective: 22-Jun-2007		□ Product Mar□ Back Mark□ Date Code☑ Other	Assembly lot	marked on the es traceability to pound type	
Contact: Geoffrey Cortes		<u> </u>			
Title: Product Quality Phone #: (408) 284-8321 Fax #: (408) 284-1450 E-mail: Geoffrey.Cortes@idt.com			¥ Yes se contact your local sa ple request & availabili	-	
DESCRIPTION AND PURPOSE OF CH	IANGE:				
Die Technology Wafer Fabrication Process Assembly Process Equipment Testing Manufacturing Site Data Sheet Other					
RELIABILITY/QUALIFICATION SUM	MARY.				
There is no impact with regards to the pack		iability.			
CUSTOMER ACKNOWLEDGMENT OF RECEIPT: IDT records indicate that you require written notification of this change. Please use the acknowledgement below or E-Mail to grant approval or request additional information. If IDT does not receive acknowledgement within 30 days of this notice it will be assumed that this change is acceptable. IDT reserves the right to ship either version manufactured after the process change effective date until the inventory on the earlier version has been depleted.					
Customer:			for shipments prior	to effective date.	
Name/Date:	E-I	Mail Address:	-		
Title:	Pho	one#/Fax#:			
CUSTOMER COMMENTS:					
IDT ACKNOWLEDGMENT OF RECE	IPT:				
RECD. BY:		DATE:			

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ATTACHMENT I - PCN #: A0702-01

PCN Type: Assembly Material Change

Data Sheet Change: None

Detail Of Change: This notification is to advise our customers that IDT is converting underfill material from

Sumitomo 4152RA to Namics U8437-2 after successful qualification.

There is no change in the moisture sensitivity level (MSL).

Please see attachment I for qualification data and attachment II for affected part number list.

Description	Affected	Material		
Description	Package Types	Old	New	
Underfill Material	24.5mm x 19.5mm FCBGA- 655	Sumitomo 4152RA	Namics U8437-2	

Sample Availability: Samples are not built ahead of the change and are limited to selective devices. Please

contact your local IDT sales representative for sample request and availability.

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ATTACHMENT I - PCN #: A0702-01

Qualification Plan #: P06-06-05R1

Test Vehicle: 24.5mm x 19.5mm FCBGA-655 (1 lot)

Qualification Test Plan and Results:

Test Description	Test Method (Latest specs in effect)	Number of Lot	Test Results (SS/Rej)
* Temperature Cycling (Cond B, 1000 cycles)	JESD22-A104	1	45/0
* Unbiased HAST (130°C, 85% RH, 100 hours)	JESD22-A118	1	45/0
High Temperature Stabilization Bake (150 °C, 1000 hours)	JESD22-A103	1	77/0
Moisture Sensitivity Classification, L4	J-STD-020	1	45/0

Note: * Test require moisture pre-conditioning sequence per JESD22-A113.

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ATTACHMENT II - PCN #: A0702-01

Affected Part Number

IDT Part Number	IDT Part Number	IDT Part Number	IDT Part Number
IDTAMB0480A3RH	IDTAMB0480ARH	IDTAMB0481A0RH	IDTAMB0482C1RH
IDTAMB0480A3RJ	IDTAMB0480ARJ	IDTAMB0481A0RJ	IDTAMB0482C1RJ
IDTAMB0480A5RH	IDTAMB0480B1RH	IDTAMB0481A1RJ	
IDTAMB0480A5RJ	IDTAMB0480B1RJ	IDTAMB0482C0RJ	

Notes: For T & R (shipping method) "8" is added to the p/n.